EMC TEST REPORT For

LIMBID (CHINA) CO., LIMITED

INTERACTIVE WHITEBOARD, TOUCH SCREEN

Model No.: BID-IR-120

Additional Model No: Please Refer To Page 26

Prepared for : LIMBID (CHINA) CO., LIMITED

Address : 15/B, 15/F CHEUK NANG PLAZA 250 HENNESSY ROAD,

HK

Prepared by : Shenzhen LCS Compliance Testing Laboratory Ltd.

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Date of receipt of test sample : June 10, 2014

Number of tested samples :

Serial number : Prototype

Date of Test : June 10, 2014 - June 16, 2014

Date of Report : June 16, 2014



EMC TEST REPORT

EN 55022: 2010

Information technology equipment-Radio disturbance characteristics-Limits of measurement

EN 55024: 2010

Information technology equipment-Immunity characteristics-Limits and methods of measurement of measurement

Report Reference No. LCS1407220878E

Date Of Issue...... June 16, 2014

Testing Laboratory Name.....: Shenzhen LCS Compliance Testing Laboratory Ltd.

Avenue, Bao'an District, Shenzhen, Guangdong, China

Testing Location/ Procedure: Full application of Harmonised standards

Partial application of Harmonised standards

Other standard testing method \square

Applicant's Name....: LIMBID (CHINA) CO., LIMITED

HK

Test Specification:

Standard : EN 55022: 2010

EN 55024: 2010

Test Report Form No...... LCSEMC-1.0

TRF Originator.....: Shenzhen LCS Compliance Testing Laboratory Ltd.

Master TRF Dated 2011-03

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Test Item Description.....: INTERACTIVE WHITEBOARD, TOUCH SCREEN

Trade Mark.....: LIMBID

Model/Type Reference BID-IR-120

Ratings DC 5V

Result Positive

Compiled by:

Supervised by:

Danny Huang

Approved by

Yoyo Wang/ File administrators

Danny Huang/ Technique principal

Gavin Liang/Manager

EMC -- TEST REPORT

Test Report No.: LCS1407220878E

June 16, 2014

Date of issue

Type / Model.....: BID-IR-120

EUT.....:: INTERACTIVE WHITEBOARD, TOUCH SCREEN

Applicant.....: : LIMBID (CHINA) CO., LIMITED

Address.....: 15/B, 15/F CHEUK NANG PLAZA 250 HENNESSY ROAD,

HK

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Address.....: 15/B, 15/F CHEUK NANG PLAZA 250 HENNESSY ROAD,

HK

Telephone.....: +852-56156535 Fax....:: +852-28935281

Test Result according to the standards on page 6: **Positive**

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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1.1. Description of Standards and Results

1. SUMMARY OF STANDARDS AND RESULTS

The EUT have been tested according to the applicable standards as referenced below.

	EMISSION (EN 55022: 2010)					
Description of Test Item Standard Limits						
Conducted disturbance at mains terminals	EN 55022: 2010	Class B	N/A			
Conducted disturbance at telecommunication port	EN 55022: 2010	Class B	N/A			
Radiated emission	EN 55022: 2010	Class B	PASS			
Harmonic current emissions	EN 61000-3-2: 2006+A1: 2009+A2: 2009	Class A	N/A			
Voltage fluctuations & flicker	EN 61000-3-3: 2013		N/A			
	IMMUNITY (EN 55024: 2010)					
Description of Test Item	Basic Standard	Performan ce Criteria	Results			
Electrostatic discharge (ESD)	EN 61000-4-2: 2009	В	PASS			
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A1: 2008+A2: 2010	А	PASS			
Electrical fast transient (EFT)	EN 61000-4-4: 2012	В	N/A			
Surge (Input a.c. power ports)	EN 61000-4-5: 2006	В	N/A			
Radio-frequency, Continuous conducted disturbance	EN 61000-4-6: 2013	А	N/A			
Power frequency magnetic field	EN 61000-4-8: 2010	А	PASS			
Voltage dips, >95% reduction		В	N/A			
Voltage dips, 30% reduction	EN 61000-4-11: 2004	С	N/A			
Voltage interruptions		С	N/A			
N/A is an abbreviation for Not App	licable.					

1.2. Description of Performance Criteria

General Performance Criteria

Examples of functions defined by the manufacturer to be evaluated during testing include, but are not limited to, the following:

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- essential operational modes and states;
- tests of all peripheral access (hard disks, floppy disks, printers, keyboard, mouse, etc.);
- quality of software execution;
- quality of data display and transmission;
- quality of speech transmission.

1.2.1. Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacture when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deriver from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.2. Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacture, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operation state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be deriver from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

1.2.3. Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacture's instructions.

Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be loss.

2. GENERAL INFORMATION

2.1. Description of Device (EUT)

EUT : INTERACTIVE WHITEBOARD, TOUCH SCREEN

Model Number : BID-IR-120

Power Supply : DC 5V

EUT Clock Frequency: ≤108MHz

2.2. Description of Test Facility

Site Description

EMC Lab. : Accredited by CNAS, April 28, 2013

The Certificate Registration Number. is L4595.

Accredited by FCC, July 14, 2011

The Certificate Registration Number. is 899208.

Accredited by Industry Canada, May. 02, 2011 The Certificate Registration Number. is 9642A-1

Accredited by VCCI, Japan January 30, 2012

The Certificate Registration Number. is C-4260 and R-3804

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Accredited by ESMD, April 24, 2012

The Certificate Registration Number. is ARCB0108.

Accredited by UL, July 25, 2013

The Certificate Registration Number. is 100571-492.

Accredited by TUV, December 23, 2013

The Certificate Registration Number. is SCN1134

Accredited by Intertek, October 30, 2013

The Certificate Registration Number. is 2011-RTL-L1-50.

2.3. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. To CISPR 16 – 4 "Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements" and is documented in the LCS quality system acc. To DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

2.4. Measurement Uncertainty

Test Item		Frequency Range	Uncertainty	Note
Dodiction Uncontainty		30MHz~200MHz	±2.96dB	(1)
Radiation Uncertainty	:	200MHz~1000MHz	±3.10dB	(1)
Conduction Uncertainty: 15		150kHz~30MHz	±1.63dB	(1)
Power disturbance		30MHz~300MHz	±1.60dB	(1)

(1). This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3. MEASURING DEVICE AND TEST EQUIPMENT

3.1.Conducted Disturbance

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	101142	2014/06/18
2	10dB Attenuator	SCHWARZBECK	OSPAM236	9729	2014/06/18
3	Artificial Mains	ROHDE & SCHWARZ	ENV216	101288	2014/06/18
4	EMI Test Software	AUDIX	E3	N/A	2014/06/18

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3.2.Disturbance Power

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	101142	2014/06/18
2	Absorbing clamp	ROHDE & SCHWARZ	MDS 21	4033	2013/08/30
3	EMI Test Software	AUDIX	E3	N/A	2014/06/18

3.3.Radiated Electromagnetic Disturbance

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	EMI Test Receiver	ROHDE & SCHWARZ	ESCI	1011423	2014/06/18
2	Triple-loop Antenna	EVERFINE	LLA-2	11050003	2014/06/18
3	EMI Test Receiver	ROHDE & SCHWARZ	ESPI	101840	2014/06/18
4	EMI Test Software	AUDIX	E3	N/A	2014/06/18

3.4. Radiated Disturbance (Electric Field)

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	3m Semi Anechoic Chamber	SIDT FRANKONIA	SAC-3M	03CH03-HY	2013/02/04
2	EMI Test Receiver	ROHDE & SCHWARZ	ESPI	101840	2014/06/18
3	Log per Antenna	SCHWARZBECK	VULB9163	9163-470	2011/06/18
4	EMI Test Software	AUDIX	E3	N/A	2014/06/18
5	Positioning Controller	MF	MF-7082	/	2014/06/18

3.5. Harmonic Current

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power Analyzer Test System	Voltech	PM6000	20000670053	2014/06/18

3.6. Voltage fluctuation and Flicker

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power Analyzer Test System	Voltech	PM6000	20000670053	2014/06/18

3.7. Electrostatic Discharge

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	ESD Simulator	KIKUSUI	KC001311	KES4021	2013/08/30

3.8.RF Field Strength Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	SIGNAL GENERATOR	HP	8648A	625U00573	2014/06/18
2	Amplifier	AR	500A100	17034	2014/06/18
3	Amplifier	AR	100W/1000M1	17028	2014/06/18
4	Isotropic Field Monitor	AR	FM2000	16829	2014/06/18
5	Isotropic Field Probe	AR	FP2000	16755	2014/06/18
6	Bi-conic Antenna	EMCO	3108	9507-2534	2014/06/18
7	By-log-periodic Antenna	AR	AT1080	16812	2014/06/18
8	EMS Test Software	ROHDE & SCHWARZ	ESK1	N/A	2014/06/18

3.9. Electrical Fast Transient/Burst

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Electrical fast transient(EFT)generator	3CTEST	EFT-4021	EC0461044	2014/01.20
2	Coupling Clamp	3CTEST	EFTC	EC0441098	2012/06/18

3.10.Surge

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Surge test system	3CTEST	SG5006G	EC5581070	2014/06/18
2	Coupling/decoupling network	3CTEST	SGN-5010G	CS5591033	2014/06/18

3.11.Conducted Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Simulator	EMTEST	CWS500C	0900-12	2014/06/18
2	CDN	EMTEST	CDN-M2	5100100100	2014/06/18
3	CDN	EMTEST	CDN-M3	0900-11	2014/06/18
4	Attenuator	EMTEST	ATT6	0010222A	2014/06/18

3.12. Power Frequency Magnetic Field Susceptibility

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power frequency mag-field generator System	EVERFINE	EMS61000-8K	906003	2014/06/18

3.13. Voltage Dips

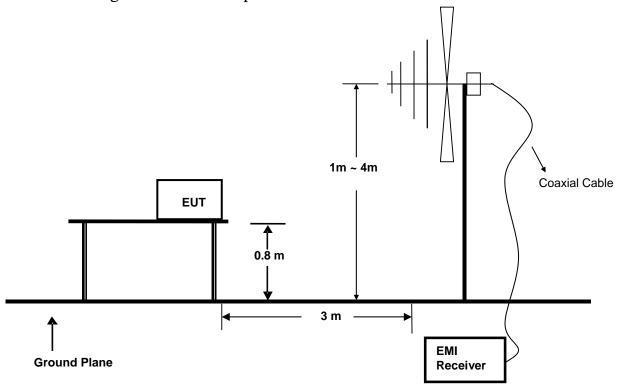
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Voltage dips and up generator	3CTEST	VDG-1105G	EC0171014	2014/06/18

3.14. Voltage Short Interruptions

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Voltage dips and up generator	3CTEST	VDG-1105G	EC0171014	2014/06/18

4. RADIATED EMISSION MEASUREMENT

4.1. Block Diagram of Test Setup



4.2. Test Standard

EN 55022: 2010

4.3. Radiated Emission Limits

EN 55022 Limits:

All emanations from a class B device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

FREQUENCY	DISTANCE	FIELD STRENGTHS LIMIT
(MHz)	(Meters)	(dBµV/m)
30 ~ 230	3	40
230 ~ 1000	3	47

Note: (1) The smaller limit shall apply at the combination point between two frequency bands.

(2) Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the EUT.

4.4. EUT Configuration on Test

The EN 55022 regulations test method must be used to find the maximum emission during radiated emission measurement.

4.5. Operating Condition of EUT

- 4.5.1. Turn on the power.
- 4.5.2. After that, let the EUT work in test mode (ON) and measure it.

4.6. Test Procedure

The EUT is placed on a turntable, which is 0.8 meter high above the ground. The turntable can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna, which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. By-log antenna (calibrated by Dipole Antenna) is used as a receiving antenna. Both horizontal and vertical polarization of the antenna is set on test.

The bandwidth of the Receiver is set at 120kHz.

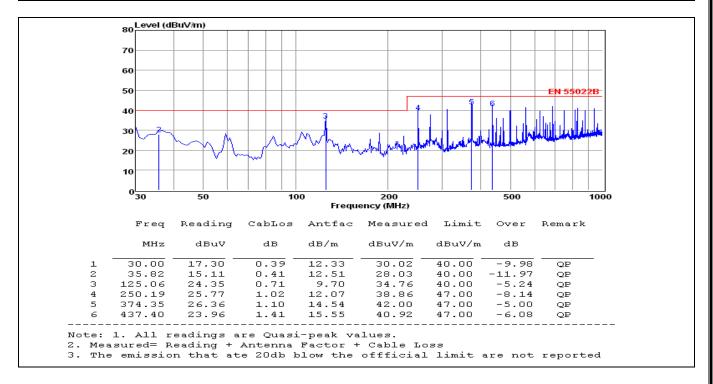
The frequency range from 30MHz to 1000MHz is investigated.

4.7. Test Results

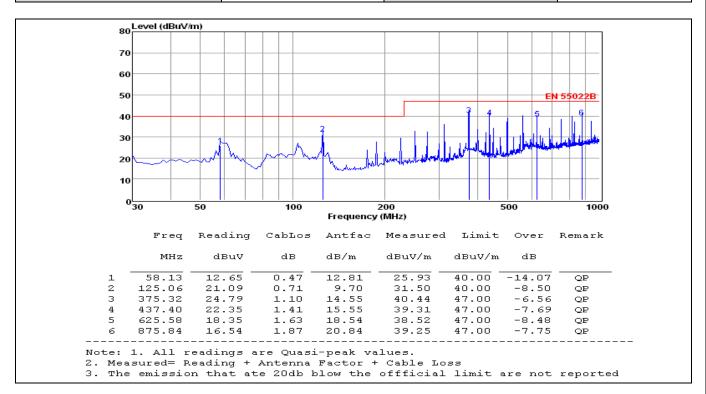
PASS

The test result please refer to the next page.

Model No.	BID-IR-120	Test Date	June 13, 2014
Environmental Conditions	24℃, 56% RH	Test Mode	ON
Pol	Vertical	Detector Function	Quasi-peak
Test Engineer	Kevin	Distance	3m

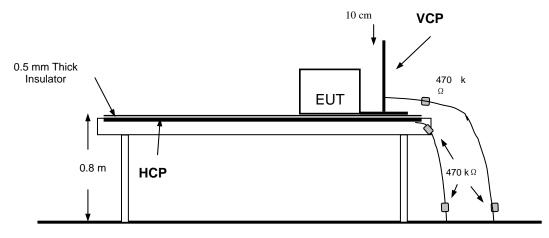


Model No.	BID-IR-120	Test Date	June 13, 2014
Environmental Conditions	24℃, 56% RH	Test Mode	ON
Pol	Horizontal	Detector Function	Quasi-peak
Test Engineer	Kevin	Distance	3m



5. ELECTROSTATIC DISCHARGE IMMUNITY TEST

5.1. Block Diagram of Test Setup



Ground

5.2. Test Standard

EN 55024: 2010 (EN 61000-4-2: 2009,

Severity Level: 3 / Air Discharge: ± 8 KV, Level: 2 / Contact Discharge: ± 4 KV)

5.3. Severity Levels and Performance Criterion

5.3.1. Severity level

Level	Test Voltage	Test Voltage
	Contact Discharge (KV)	Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
X	Special	Special

5.3.2. Performance Criterion: B

5.4. EUT Configuration on Test

The configuration of EUT is listed in Section 3.7.

5.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 4.5, Except the test set up replaced by Section 5.1.

5.6. Test Procedure

5.6.1. Air Discharge

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed

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5.6.2. Contact Discharge

All the procedure shall be same as Section 5.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

5.6.3. Indirect Discharge For Horizontal Coupling Plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

5.6.4. Indirect Discharge For Vertical Coupling Plane

At least 10 single discharge (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

5.7. Test Results

PASS

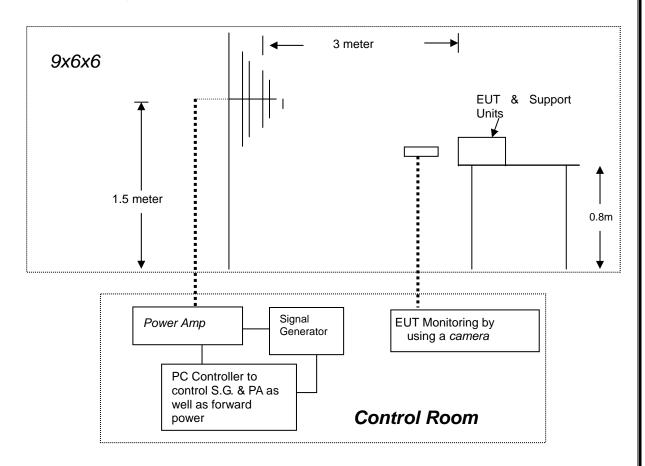
Please refer to the following pages

Electrostatic Discharger Test Results					
Standard	☐ IEC 61000-4-2 ☑ EN 61000-4-2				
Applicant	LIMBID (CHINA) CO., LIMITED				
EUT	INTERACTIVE WHITEBOARD,TOUCH SCREEN	Temperature	24℃		
M/N	BID-IR-120	Humidity	53%		
Criterion	В	Pressure	1021mbar		
Test Mode	Normal	Test Date	June 13, 2014		

Test Engineer	est Engineer Kevin								
		A	ir Discharg	ge					
		Test Levels				Re	sults		
Test Points	± 2KV	± 4KV	± 8KV	Passed		Fail	Perfori Criteri		
Front	\boxtimes	\boxtimes	\boxtimes		\overline{X}		\Box A	$\boxtimes \mathbf{B}$	
Back	\boxtimes	\boxtimes	\boxtimes		\boxtimes		\Box A	$\boxtimes \mathbf{B}$	
Left	\boxtimes	\boxtimes	\boxtimes		\leq		\Box A	⊠B	
Right	\boxtimes	\boxtimes	\boxtimes		\leq		\Box A	⊠B	
Тор	\boxtimes	\boxtimes	\boxtimes		\leq		\Box A	$\boxtimes \mathbf{B}$	
Bottom	\boxtimes	\boxtimes	\boxtimes		\leq		\Box A	$\boxtimes \mathbf{B}$	
		Cor	ntact Discha	rge					
		Test Levels				Re	sults		
Test Points	± 2 KV	± 2 KV ±4 KV		Pas	ssed	Fail	Perfori Criteri		
Front	\boxtimes		\boxtimes		$\overline{\mathbb{Z}}$			⊠B	
Back	\boxtimes		\boxtimes				\Box A	⊠B	
Left	\boxtimes				$\overline{\mathbf{A}}$		\Box A	\boxtimes B	
Right			\boxtimes		$\overline{\mathbf{A}}$		\Box A	⊠B	
Тор	\boxtimes				$\overline{\mathbb{Z}}$			⊠B	
Bottom	\boxtimes				\leq			⊠B	
	Dis	charge To l	Horizontal (Coupl	ing Pl	ane			
		Test Levels				Re	sults		
Side of EUT	± 2 KV	- -	± 4 KV	Pa	assed	Fail	Perforn Criterio		
Front	\boxtimes				$\overline{\mathbf{A}}$		\Box A	⊠B	
Back	\boxtimes		\boxtimes		\overline{A}		\Box A	\boxtimes B	
Left	\boxtimes				\overline{A}		\Box A	\boxtimes B	
Right	\boxtimes		\boxtimes		\leq		\Box A	$\boxtimes \mathbf{B}$	
	D	ischarge To	Vertical Co	ouplin	ıg Plaı	ne			
		Test Levels				Re	sults		
Side of EUT	± 2 KV	•	± 4 KV		Passed Fail		Perforn Criterio	Performance Criterion	
Front					$\overline{\langle}$		\Box A	⊠B	
Back	\boxtimes		\boxtimes		\leq		\Box A	\boxtimes B	
Left	\boxtimes		\boxtimes		\leq		\Box A	$\boxtimes \mathbf{B}$	
Right					\leq		\Box A	$\boxtimes \mathbf{B}$	

6. RF FIELD STRENGTH SUSCEPTIBILITY TEST

6.1. Block Diagram of Test



6.2. Test Standard

EN 55024: 2010

(EN 61000-4-3: 2006+A1: 2008+A2: 2010 Severity Level: 2, 3V / m)

6.3. Severity Levels and Performance Criterion

6.3.1. Severity Levels

Level	Field Strength (V/m)
1.	1
2.	3
3.	10
X.	Special

6.3.2. Performance Criterion: A

6.4. EUT Configuration on Test

The configuration of the EUT is same as Section 2.1.

6.5. Operating Condition of EUT

Same as radiated emission measurement, which is listed in Section 4.5, except the test setup replaced as Section 6.1.

6.6. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually. In order to judge the EUT performance, a CCD Recording is used to monitor its screen. All the scanning conditions are as following:

Condition of Test		Remark	
1.	Fielded Strength	3V/m (Severity Level 2)	
2.	Radiated Signal	Unmodulated	
3.	Scanning Frequency	80-1000MHz	
4.	Sweep time of radiated	0.0015 Decade/s	
5.	Dwell Time	3 Sec.	

6.7. Test Results

PASS

Please refer to the following page.

RF Field Strength Susceptibility Test Results				
Standard	☐ IEC 61000-4-3 ☑ EN 61000-4-3			
Applicant	LIMBID (CHINA) CO., LIMITED			
EUT	INTERACTIVE WHITEBOARD,TOUCH SCREEN	Temperature	24°C	
M/N	BID-IR-120	Humidity	53%	
Field Strength 3 V/m		Criterion	A	
Test Mode	Normal	Test Engineer	Kevin	
Frequency Range	80 MHz to 1000 MHz	Test Date	June 13, 2014	
Modulation □ None □ Pulse ☑ AM 1KHz 80%				
Steps	1%			

	Horizontal	Vertical
Front	PASS	PASS
Right	PASS	PASS
Rear	PASS	PASS
Left	PASS	PASS

Test Equipment:

1. Signal Generator: 2031 (MARCONI)

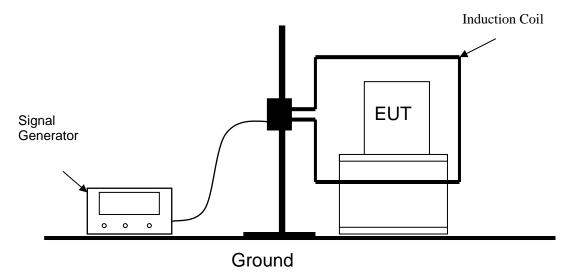
Power Amplifier: 500A100 & 100W/1000M1 (A&R)
 Power Antenna: 3108 (EMCO) & AT1080 (A&R)

4. Field Monitor: FM2000 (A&R)

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7. MAGNETIC FIELD SUSCEPTIBILITY TEST

7.1. Block Diagram of Test Setup



7.2. Test Standard

EN 55024: 2010

(EN 61000-4-8: 2010, Severity Level: Level 1, 1A / m)

7.3. Severity Levels and Performance Criterion

7.3.1. Severity Levels

Level	Field Strength (A/m)
1	1
2	3
3	10
4	30
5	100
X	Special

7.3.2. Performance Criterion: A

7.4. EUT Configuration on Test

The configuration of the EUT is same as Section 2.1.

7.5. Test Procedure

The EUT is placed in the middle of a induction coil (1*1m), under which is a 1*1*0.1m (high) table, this small table is also placed on a larger table, 0.8 m above the ground. Both horizontal and vertical polarization of the induction coil is set on test, so that each side of the EUT is affected by the magnetic field. Also can reach the same aim by change the position of the EUT.

7.6. Test Results

PASS.

Please refer to the following page.

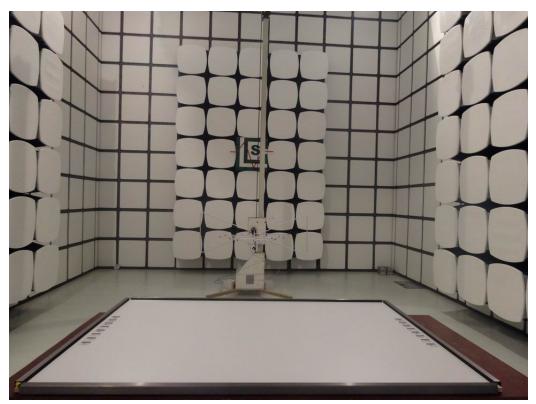
Magnetic Field Immunity Test Result				
Standard	□ IEC 61000-4-8 ☑ EN 61000-4-8			
Applicant	LIMBID (CHINA) CO., LIMITED			
EUT	INTERACTIVE WHITEBOARD,TOUCH SCREEN	Temperature	24°C	
M/N	BID-IR-120	Humidity	53%	
Test Mode Normal		Criterion	A	
Test Engineer Kevin		Test Date	June 13, 2014	

Test Level (A/M)	Testing Duration	Coil Orientation	Criterion	Result
1	5 mins	X	A	PASS
1	5 mins	Y	A	PASS
1	5 mins	Z	A	PASS

Note:

8. PHOTOGRAPH

8.1. Photo of Radiated Measurement



8.2. Photo of Electrostatic Discharge Test



9. EXTERNAL AND INTERNAL PHOTOS OF THE EUT



Fig. 1



Fig. 2

10. MANUFACTURER/ APPROVAL HOLDER DECLARATION

The following identical l(s):

BID-IR-***, BID-OP-***, BID-EM-***, BID-DV-***, BID-CP-***, BID-GL2D-***, BID-GL3D-***(There *** may be 015-120, it means the screen size)

Belong to the tested device:

Product description : INTERACTIVE WHITEBOARD, TOUCH

SCREEN

Model name : BID-IR-120

Remark: PCB board, structure and internal of these model(s) are the same, So no additional models were tested.

-----THE END OF REPORT-----